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(Modified) PATENT AND TRADEMARK OFFICE			276730US90PCT		New U.S. PCT Application Based on PCT/JP04/01233			
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FIST)F REFE	ERENCES CITED BY A	PPLICANT	Takashi KARIYA, et al.		10/	10/546620	
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				U.S. PATENT DOCUMENTS				
EXAMINEI INITIAL		DOCUMENT NUMBER	DATE	NAME .	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
	AA							
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FOREIGN PATENT DOCUMENTS								
	DOCUMENT DATE		COUNTRY			TRANSLATION		
/TD/	AG	2002-271025	09/20/02	JP(English abstract only)		YES	S NO	
	AH	2000-332057	11/30/00	JP(English abstract only)		 	NO	
	Al	11-168150	06/22/99	JP(English abstract only)		 	NO	
	AJ.	2001-230515	08/24/01	JP(English abstract only)		-	NO	
	AK	2001-332866	11/30/01	JP(English abstract only)			NO	
	AL	2001-015932	01/19/01	JP(English abstract only)			NO	
·	AM	07-263869	10/13/95	JP(English abstract only)		·	NO	
	AN	2002-362937	12/18/02	JP(English abstract only)			NO	
	AO	63-234552	09/29/88	JP(English abstract only)			NO	
	AP	63-047961	02/29/88	JP(English abstract only)			NO	
	AQ	2000-077454	03/14/00	JP(English abstract only)			NO	
	AR	2002-299775	10/11/02	JP(English abstract only)			NO	
V	AS	2002-236229	08/23/02	JP(English abstract only)			NO	
	AT	11-097583	04/09/99	JP(English abstract only)			NO	
/TD/	AU	2002-100870	04/05/02	JP(English abstract only)			NO	
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
	AW					·		
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	AZ				Addit	ional Refe	rences sheet(s) attached	
Examiner		/Tuan Dinh/			Date Con	sidered	12/19/2007	
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